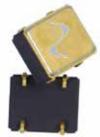
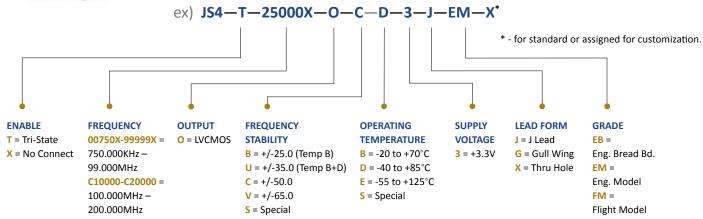
Space Level Clock Oscillator





8.89L x 7.37W x 4.32H (mm)

Wi2Wi's *JS4 Series*, utilizing a premium swept quartz crystal resonator, is designed for low-to-mid orbit applications and manufactured in Wi2Wi's own MIL-PRF-55310/QPL certified manufacturing facility. (Higher Orbits available upon request)



Parameter		Supply Voltage (±10%)	Unit	
Par	ameter	3.3	V	
Frequency Range ^{*1}		750KHz to 200MHz		
Frequency Stability*1	All Causes (Maximum)*2	Per Option	ppm	
	Operating	Per Option	°C	
Temperature Range ^{*1}	Storage	- 55 to +125	°C	
	0.750000 to 23.999999 MHz	15		
6 1 6 1 (0.4)	24.000000 to 49.999999 MHz	20		
Supply Current (Maximum)	50.000000 to 69.999999 MHz	30	mA	
	70.000000 to 200.000000 MHz	45		
	Ioh: Voh = Vdd-0.4V, Vdd = 3.3V	40.0/84:	mA	
Output Drive Current (Low Drive)	Iol: Vol = 0.4V, Vdd = 3.3V	10.0 (Minimum)		
	Ioh: Voh = Vdd-0.4V, Vdd = 3.3V	20.0 (2.1)	mA	
Output Drive Current (High Drive)	Iol: Vol = 0.4V, Vdd = 3.3V	30.0 (Minimum)		
Output		LVCMOS		
Load		15pF		
Duty Cycle (at 50% Vcc)		40% to 60% (45% to 55% option)		
	0.750000 to 23.999999 MHz	10		
Rise/Fall Times (Maximum) (10% to 90% Vcc)	24.000000 to 49.999999 MHz	7		
	50.000000 to 69.999999 MHz	4	nS	
	70.000000 to 200.000000 MHz	3		
Start up Time (Maximum)		10	mS	
	Voh: High (Minimum)	90	0/ 1/	
Output Voltage Levels	Vol: Low (Maximum)	10	% Vc	
	Vih: High or Open (Enabled)	80	% Vc	
	Vil: Low or Ground (Disabled)*3	20	% Vc	
Pin 1 (Tri-State) (Option)	Disable Current (Maximum)*3	10	μΑ	
	Disable Delay Time (Maximum)	150	nS	

^{*1 -} Not all Frequency/Temperature/Voltage combinations are available.

	rev: NA	SIZE: A	CAGE: A	1 of 5
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^{*2 -} Inclusive of Tolerance @25°C, Operating Temperature, Supply Voltage, Load, 1st Year Aging, Shock and Vibration.

^{*3 -} Internal crystal oscillation halted.

JS4-Series 8.89 x 7.37 x 4.32 (mm)



Absolute Maximum Ratings

PARAMETER	SYM	MIN	MAX	UNIT
Frequency Range		.750	200	MHz
Supply Voltage	Vdd		4.6	V
Input Voltage	VI	-0.5	Vdd+0.5 V	
Output Voltage	VO	-0.5	Vdd+0.5 V	
Storage Temperature	TS	-55	+125	°C
Ambient Operating Temperature	TA	-55	+125	°C
Junction Temperature	TJ		+125	°C
ESD Protection Human Body Model			2	kV
Radiation, Total Ionized Dose	TID		100	Krad
Single Event Latch Up Immunity	SEL		64	MeV-cm ² /mg

MIL-55310 SCREENING

MIL-PRF-55310 Group A & B Screening – Grades EM (Upon Request) & FM Only				
Operation	Requirements	Sample Size		
	Screening			
Internal Visual (Pre Cap)	MIL-STD-883, Method 2017 and 2032 NASA-STD-8739.3	100%		
Stabilization Bake	MIL-STD-883, Method 1008	100%		
Resistance Weld	per this specification 7.5 ML 001 welding process	100%		
Seal Test	MIL-STD-202, Method 112, Condition C & D or E	100%		
Thermal Shock	MIL-STD-202, Method 107, Test Condition A1	100%		
Initial Electrical Test The electrical parameters with limits to be measured, should be indicated in dedicated tables of a procurement specification. (Per Source Control Drawing) Burn-In MIL-STD-883, Method 1015		100%		
		100%		
Electrical Test	The electrical parameters with limits to be measured, should be indicated in dedicated tables of a procurement specification. (Per Source Control Drawing)	100%		
Radiographic Inspection MIL-STD-202, Method 209		100%		
Group A				
Electrical Test	The electrical parameters with limits to be measured, should be indicated in dedicated tables of a procurement specification. (Per Source Control Drawing)	100%		
Visual & Mechanical Inspection	Per source control drawing	100%		
Solderability	MIL-STD-202, Method 208	5 Empty Packages		
Group B				
Electrical Testing	The electrical parameters with limits to be measured, should be indicated in dedicated tables of a procurement specification. (Per Source Control Drawing)	100%		

REV: NA	SIZE: A	CAGE: A	2 of 5



MIL-55310 SCREENING

MIL-PRF-55310 Group C Screening – FM Only			
Operation	Requirements	Sample Size	
	Group C Inspection MIL-PRF-55310 (Subgroup 1) - 8 Samples		
Vibration	MIL-STD-202, Method 204 (Customer specifies test conditions)	8	
Shock	MIL-STD-202, Method 213, Condition C	8	
G	roup C Inspection MIL-PRF-55310 (Subgroup 2) - 4 Samples from Subgroup 1		
Thermal Shock	MIL-STD-202, Method 107, Condition B	4	
Ambient Pressure	MIL-PRF-55310, Paragraph 4.8.46.1	4	
Storage Temperature	MIL-PRF-55310, Paragraph 4.8.47	4	
Radiation Hardness	MIL-PRF-55310, Paragraph 4.8.48	AR	
Group C Inspection MIL-PRF-55310 (Subgroup 3) - 2 Samples from Subgroup 1			
Resistance to Soldering Heat	MIL-PRF-55310, Paragraph 4.8.49	Χ	
Moisture Resistance	MIL-STD-202, Method 106 (Omit step 7b)	Х	
Salt Atmosphere	MIL-STD-883, Method 1009, Condition A (Test not required for class two oscillators if the test was performed on the package level per customer approval)	X	
Group C Inspection MIL-PRF-55310 (Subgroup 4) - 2 Samples from Subgroup 1			
Terminal Strength (Lead integrity)	MIL-PRF-55310, Paragraph 4.8.52	Х	
Resistance to Solvents	MIL-STD-202, Method 215 (Not required for laser marked devices)	AR	

Laboratory Suitability Certified MIL-STD-790 Product Assurance Certified



ISO 9001 FM 75597

REV: NA SIZE: A CAGE: A 3 of 5

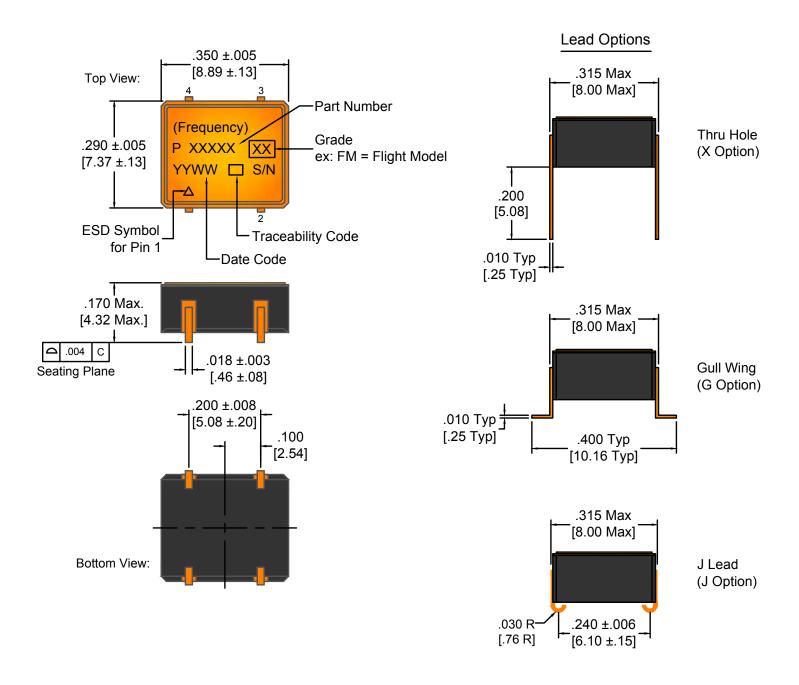
JS4-Series 8.89 x 7.37 x 4.32 (mm)



PACKAGE DIMENSIONS

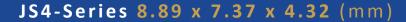
Tolerance: ±.008 [.20mm] (Unless otherwise specified)

PIN	CONNECTION	
1	Tri-State or No Connect	
2	Ground/Case	
3	Output	
4	4 Supply Voltage	



Leads: Electro Au, 11.8 to 40.0 μ m (.30 to 1.0 μ m) over Electro Ni, 50 to 350 μ m (1.27 to 8.89 μ m)

SEL NIA	a.== A	0.05 A	4 -t -
REV: NA	SIZE: A	CAGE: A	4 OT 5
	1		





- 1. Material: Black Conductive Polystyrene or equivalent.
- **2**. 10 Sprocket Hole pitch cumulative tolerance of \pm .008.

Tape and Reel for J-Lead and Gull Wing only.

- 3. Camber in compliance with EIA 481.
- **4**. Empty pockets: Trailing end (Minimum) 200 mm. and Leading end (Minimum) 400 mm.
- **5**. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.

